

16-Bit, Isolated Sigma-Delta Modulator, LVDS Interface

FEATURES

- ▶ 5 MHz to 20 MHz external clock input rate
- ▶ 16 bits, no missing codes
- ▶ Signal-to-noise ratio (SNR): 88 dB typical
- ▶ Effective number of bits (ENOB): 14.2 bits typical
- Typical offset drift vs. temperature: 1.6 μV/°C
- ▶ Low voltage differential signaling (LVDS) interface
- ▶ On-board digital isolator
- ▶ On-board reference
- ▶ Full-scale analog input voltage range: ±320 mV
- ► -40°C to +125°C operating temperature range
- ▶ High common-mode transient immunity: >25 kV/µs
- ▶ 16-lead, wide-body SOIC_IC, with increased creepage package
- Safety and regulatory approvals
 - ▶ UL 1577
 - \triangleright V_{ISO} = 5000 V rms for 1 minute
 - ▶ IEC/CSA 62368-1
 - ▶ IEC/CSA 60601-1
 - ▶ DIN EN IEC 60747-17 (VDE 0884-17)
 - \triangleright V_{IORM} = 1250 V_{PEAK}

APPLICATIONS

- Shunt current monitoring
- ▶ AC motor controls
- Power and solar inverters
- ▶ Wind turbine inverters
- Data acquisition systems
- Analog-to-digital and opto-isolator replacements

FUNCTIONAL BLOCK DIAGRAM

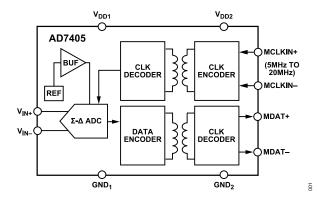


Figure 1.

GENERAL DESCRIPTION

The AD7405¹ is a high performance, second-order, Σ - Δ modulator that converts an analog input signal into a high speed, single-bit LVDS data stream, with on-chip digital isolation based on Analog Devices, Inc., iCoupler® technology. The AD7405 operates from a 4.5 V to 5.5 V (V_{DD1}) power supply and accepts a differential input signal of ±250 mV (±320 mV full-scale). The differential input is ideally suited to shunt voltage monitoring in high voltage applications where galvanic isolation is required.

The analog input is continuously sampled by a high performance analog modulator, and converted to a ones density digital output stream with a data rate of up to 20 MHz. The original information can be reconstructed with an appropriate digital filter to achieve 88 dB SNR at 78.1 kSPS. The LVDS input/output can use a 3 V to 5.5 V supply (V_{DD2}).

The LVDS interface is digitally isolated. The LVDS interface technology, combined with monolithic transformer technology, means the on-chip isolation provides outstanding performance characteristics, superior to alternatives such as optocoupler devices. The AD7405 device is offered in a 16-lead, wide-body SOIC_IC package and has an operating temperature range of -40°C to +125°C.

Analog Devices is in the process of updating documentation to provide terminology and language that is culturally appropriate. This is a process with a wide scope and will be phased in as quickly as possible. Thank you for your patience.

¹ Protected by U.S. Patents 5,952,849; 6,873,065; and 7,075,329.





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SPECIFICATIONS

 V_{DD1} = 4.5 V to 5.5 V, V_{DD2} = 3 V to 5.5 V, V_{IN+} = -250 mV to +250 mV, V_{IN-} = 0 V, T_A = -40°C to +125°C, f_{MCLKIN} = 5 MHz to 20 MHz, tested with sinc3 filter, 256 decimation rate, as defined by Verilog code, unless otherwise noted. For f_{MCLKIN} > 16 MHz, mark space ratio is 48/52 to 52/48, and V_{DD1} = 5 V ± 5%. All voltages are relative to their respective ground.

Table 1.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
STATIC PERFORMANCE						
Resolution		16			Bits	Filter output truncated to 16 bits
Integral Nonlinearity ¹	INL		±2	±12	LSB	
Differential Nonlinearity ¹	DNL			±0.99	LSB	Guaranteed no missing codes to 16 bits
Offset Error ¹			±0.2	±0.75	mV	
Offset Drift vs. Temperature			1.6	3.8	μV/°C	
'			1.3	3.1	μV/°C	0°C to 85°C
Offset Drift vs. V _{DD1}			50		μV/V	
Gain Error ¹			±0.2	±0.8	% FSR	f _{MCLKIN} = 16 MHz
			±0.2	±0.8	% FSR	$f_{MCLKIN} = 20 \text{ MHz}, T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$
			±0.2	±1.2	% FSR	f _{MCLKIN} = 20 MHz
Gain Error Drift vs. Temperature			65	95	ppm/°C	-WICERIN _5
			40	60	μV/°C	
Gain Error Drift vs. V _{DD1}			±0.6		mV/V	
ANALOG INPUT						
Input Voltage Range		-320		+320	mV	Full-scale range
input voltage range		-250		+250	mV	For specified performance
Input Common-Mode Voltage Range		200	-200 to +300	200	mV	To openiou periormanee
Dynamic Input Current			±45	±50	μA	V _{IN+} = ±250 mV, V _{IN-} = 0 V
Dynamic input durient			0.05	±00	μA	$V_{IN+} = 0 \text{ V}, V_{IN-} = 0 \text{ V}$
DC Leakage Current			±0.01	±0.6	μA	V _{IN+} = 0 V, V _{IN-} = 0 V
Input Capacitance			14	±0.0	pF	
DYNAMIC SPECIFICATIONS			14		þΓ	V _{IN+} = 1 kHz
	OINIAD	0.4	07		חו	V _{IN+} - I KHZ
Signal-to-Noise-and-Distortion Ratio ¹	SINAD	81	87		dB	40004 - 20500
0: 11 N : D : 1	ONID	83	87		dB	-40°C to +85°C
Signal-to-Noise Ratio ¹	SNR	86	88		dB	
Total Harmonic Distortion ¹	THD		-96		dB	
Peak Harmonic or Spurious Noise ¹	SFDR		- 97		dB	
Effective Number of Bits ¹	ENOB	13.1	14.2		Bits	
		13.4	14.2		Bits	-40°C to +85°C
Noise Free Code Resolution ¹		14			Bits	
ISOLATION TRANSIENT IMMUNITY ¹		25	30		kV/µs	
LVDS I/O (ANSI-644)						
Differential Output Voltage	V _{OD}	247	360	454	mV	$R_L = 100 \Omega$
Common-Mode Output Voltage	V _{OCM}	1125	1260	1375	mV	RL = 100 Ω
Differential Input Voltage	V _{ID}	150		650	mV	
Common-Mode Input Voltage	V _{ICM}	800		1575	mV	
POWER REQUIREMENTS						
V_{DD1}		4.5		5.5	V	
V_{DD2}		3		5.5	V	
I _{DD1}			30	36	mA	V _{DD1} = 5.5 V
I_{DD2}			18	22	mA	V _{DD2} = 5.5 V
			13	15	mA	V _{DD2} = 3.3 V

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SPECIFICATIONS

Table 1. (Continued)

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
Power Dissipation			264	319	mW	V _{DD1} = V _{DD2} = 5.5 V
			208	248	mW	V _{DD1} = 5.5 V, V _{DD2} = 3.3 V

¹ See the Terminology section.

TIMING SPECIFICATIONS

 V_{DD1} = 4.5 V to 5.5 V, V_{DD2} = 3 V to 5.5 V, T_A = -40°C to +125°C, unless otherwise noted. Sample tested during initial release to ensure compliance. It is recommended to read the MDAT signal on the MCLKIN+ rising edge.

Table 2.

Parameter ¹	Limit at T _{MIN} , T _{MAX}	Unit	Description
MCLKIN	5	MHz minimum	Main clock input frequency
	20	MHz maximum	
1			Data access time after MCLKIN+ rising edge
	30	ns maximum	$V_{DD2} = 4.5 \text{ V to } 5.5 \text{ V}$
	40	ns maximum	V _{DD2} = 3 V to 3.6 V
2			Data hold time after MCLKIN+ rising edge
	10	ns minimum	$V_{DD2} = 4.5 \text{ V to } 5.5 \text{ V}$
	10	ns minimum	$V_{DD2} = 3 \text{ V to } 3.6 \text{ V}$
3			Main clock low time
	0.45 × t _{MCLKIN}	ns minimum	f _{MCLKIN} ≤ 16 MHz
	0.48 × t _{MCLKIN}	ns minimum	16 MHz < f _{MCLKIN} ≤ 20 MHz
4			Main clock high time
	0.45 × t _{MCLKIN}	ns minimum	f _{MCLKIN} ≤ 16 MHz
	0.48 × t _{MCLKIN}	ns minimum	16 MHz < f _{MCLKIN} ≤ 20 MHz

Sample tested during initial release to ensure compliance.

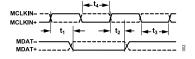


Figure 2. Data Timing

PACKAGE CHARACTERISTICS

Table 3.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
Resistance (Input to Output) ¹	R _{I-O}		10 ¹²		Ω	
Capacitance (Input to Output) ¹	C _{I-O}		2.2		pF	f = 1 MHz
IC Junction to Ambient Thermal Resistance	θ_{JA}		45		°C/W	Thermocouple located at center of package underside, test conducted on 4-layer board with thin traces

¹ The device is considered a 2-terminal device: Pin 1 to Pin 8 are shorted together, and Pin 9 to Pin 16 are shorted together.

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SPECIFICATIONS

INSULATION AND SAFETY RELATED SPECIFICATIONS

Table 4.

Parameter		Value	Unit	Test Conditions/Comments
Input to Output Momentary Withstand Voltage	V _{ISO}	5000 min	V	1 minute duration
Minimum External Air Gap (Clearance)		8.7 min ^{1, 2}	mm	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L(102)	8.7 min ¹	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		18 min	μm	Distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>400	V	DIN IEC 112/VDE 0303 Part 1 ³
Material Group		II		Material Group per IEC 60664-1 ³

¹ In accordance with IEC 60950-1/IEC 62368-1/IEC 60601-1 guidelines for the measurement of creepage and clearance distances for a pollution degree of 2 and altitudes ≤2000 meters.

REGULATORY INFORMATION

The AD7405 certification approvals are listed in Table 5.

Table 5.

UL ¹	CSA	VDE (Pending) ²
UL 1577	IEC/CSA 62368-1	DIN EN IEC 60747-17 (VDE 0884-17)
Single Protection, 5000 V rms	Basic Insulation, 870 V rms	Reinforced insulation, 1250 V _{PEAK}
	Reinforced Insulation, 435 V rms	
	IEC/CSA 60601-1	
	Basic insulation (1MOPP), 500 V rms	
	Reinforced insulation (2MOPP), 50 V rms	
File E214100	File No, 205078	File (Pending)

¹ In accordance with UL 1577, each AD7405 is proof tested by applying an insulation test voltage ≥6000 V rms for 1 second (current leakage detection limit = 15 μA).

DIN EN IEC 60747-17 (VDE 0884-17) INSULATION CHARACTERISTICS

This isolator is suitable for reinforced electrical isolation only within the safety limit data. Maintenance of the safety data is ensured by means of protective circuits.

Table 6.

Description	Symbol	Characteristic	Unit
OVERVOTLAGE CATEGORY PER IEC 60664-1			
For Rated Mains Voltage ≤300 V rms		I to IV	
For Rated Mains Voltage ≤450 V rms		I to IV	
For Rated Mains Voltage ≤600 V rms		I to IV	
For Rated Mains Voltage ≤1000 V rms		I to IV	
CLIMATIC CLASSIFICATION		40/105/21	
POLLUTION DEGREE (DIN VDE 0110, TABLE 1)		2	
MAXIMUM REPETITIVE ISOLATION VOLTAGE	V _{IORM}	1250	V _{PEA}
MAXIMUM WORKING INSULATION VOLTAGE	V _{IOWM}	884	V rms

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² Consideration must be given to pad layout to ensure the minimum required distance for clearance is maintained.

³ CSA CTI rating for the AD7405 is >400 V and a Material Group II isolation group.

In accordance with DIN EN IEC 60747-17 (VDE 0884-17), each AD7405 is proof tested by applying an insulation test voltage of ≥2344 V_{PEAK} for 1 second (partial discharge detection limit = 5 pC).

SPECIFICATIONS

Table 6. (Continued)

Description	Symbol	Characteristic	Unit
INPUT TO OUTPUT TEST VOLTAGE, METHOD B1			
$V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test, $t_m = 1$ Second, Partial Discharge < 5 pC	V _{PD(M)}	2344	V _{PEAK}
INPUT TO OUTPUT TEST VOLTAGE, METHOD A	V _{PR(M)}		
After Environmental Test Subgroup 1			
$V_{IORM} \times 1.6 = V_{PR}$, $t_m = 60$ Seconds, Partial Discharge < 5 pC		2000	V _{PEAK}
After Input and/or Safety Test Subgroup 2/ Safety Test Subgroup 3			
$V_{IORM} \times 1.2 = V_{PR}$, $t_m = 60$ Seconds, Partial Discharge < 5 pC		1500	V _{PEAK}
MAXIMUM TRANSIENT ISOLATION VOLTAGE (TRANSIENT OVERVOLTAGE, t _{TR} = 10 Seconds)	V _{IOTM}	8000	V _{PEAK}
MAXIMUM IMPULSE VOLTAGE (TESTED IN AIR, 1.2 μs/50 μs WAVEFORM PER IEC 61000-4-5)	V _{IMP}	8000	V _{PEAK}
MAXIMUM SURGE ISOLATION VOLTAGE			
(Tested in Oil, 1.2 μs/50 μs Waveform per IEC 61000-4-5, V _{TEST} = V _{IOSM} × 1.3 kV or ≥10 kV)	V _{IOSM}	12000	V _{PEAK}
SAFETY LIMITING VALUES (MAXIMUM VALUE ALLOWED IN THE EVENT OF A FAILURE, SEE Figure 3)			
Case Temperature	T _S	150	°C
Side 1 (P _{VDD1}) and Side 2 (P _{VDD2}) Power Dissipation	P _{SO}	2.78	W
INSULATION RESISTANCE AT T _S , V _{IO} = 500 V	R _{IO}	>10 ⁹	Ω

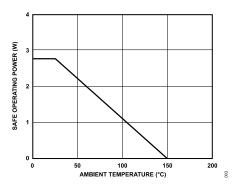


Figure 3. Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN EN IEC 60747-17 (VDE 0884-17)

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ABSOLUTE MAXIMUM RATINGS

 T_A = 25°C, unless otherwise noted. All voltages are relative to their respective ground.

Table 7.

Parameter	Rating
V _{DD1} to GND ₁	-0.3 V to +6.5 V
V _{DD2} to GND ₂	-0.3 V to +6.5 V
Analog Input Voltage to GND ₁	-1 V to V _{DD1} + 0.3 V
Digital Input Voltage to GND ₂	-0.3 V to V _{DD2} + 0.5 V
Output Voltage to GND ₂	-0.3 V to V _{DD2} + 0.3 V
Input Current to Any Pin Except Supplies ¹	±10 mA
Operating Temperature Range	-40°C to +125°C
Storage Temperature Range	-65°C to +150°C
Junction Temperature	150°C
Pb-Free Temperature, Soldering	
Reflow	260°C
ESD	2 kV
FICDM ²	±1250 V
HBM ³	±4000 V

Transient currents of up to 100 mA do not cause silicon controlled rectifier (SCR) to latch up.

- 2 JESD22-C101; RC Network: 1 $\Omega,$ Cpkg; Class: IV.
- 3 ESDA/JEDEC JS-001-2011; RC Network: 1.5 k Ω , 100 pF; Class: 3A.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

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PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

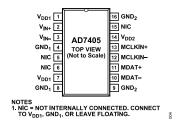


Figure 4. Pin Configuration

Table 8. Pin Function Descriptions

Pin No.	Mnemonic	Description
1, 7	V _{DD1}	Supply Voltage, 4.5 V to 5.5 V. This pin is the supply voltage for the isolated side of the AD7405 and is relative to GND ₁ . For device operation, connect the supply voltage to both Pin 1 and Pin 7. Decouple each supply pin to GND ₁ with a 10 μF capacitor in parallel with a 1 nF capacitor.
2	V _{IN+}	Positive Analog Input.
3	V _{IN} -	Negative Analog Input. Normally connected to GND ₁ .
4, 8	GND ₁	Ground 1. This pin is the ground reference point for all circuitry on the isolated side.
5, 6, 15	NIC	Not Internally Connected. Connect to V _{DD1} , GND ₁ , or leave floating.
9, 16	GND ₂	Ground 2. This pin is the ground reference point for all circuitry on the nonisolated side.
10, 11	MDAT-, MDAT+	LVDS Data Outputs. The conversion data is output serially on these pins.
12, 13	MCLKIN-, MCLKIN+	LVDS Clock Inputs. Conversion results are shifted out on the rising edge of MCLKIN+.
14	V_{DD2}	Supply Voltage, 3 V to 5.5 V. This pin is the supply voltage for the nonisolated side and is relative to GND ₂ . Decouple this supply to GND ₂ with a 100 nF capacitor.

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TYPICAL PERFORMANCE CHARACTERISTICS

 $T_A = 25$ °C, $V_{DD1} = 5$ V, $V_{DD2} = 5$ V, $V_{IN+} = -250$ mV to +250 mV, $V_{IN-} = 0$ V, $f_{MCLKIN} = 20$ MHz, using a sinc3 filter with a 256 oversampling ratio (OSR), unless otherwise noted.

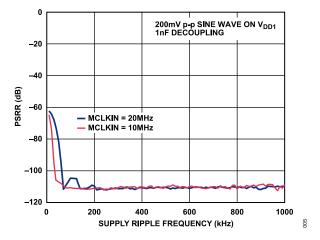


Figure 5. PSRR vs. Supply Ripple Frequency

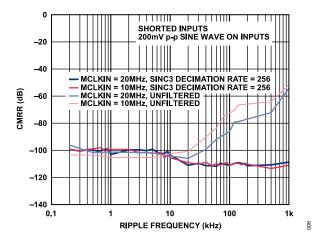


Figure 6. CMRR vs. Common-Mode Ripple Frequency

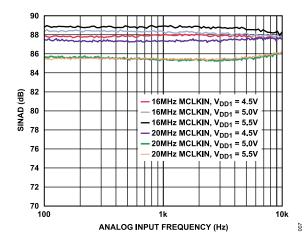


Figure 7. SINAD vs. Analog Input Frequency

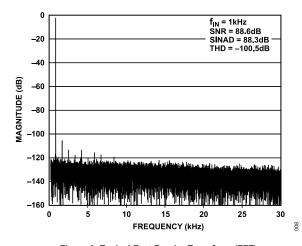


Figure 8. Typical Fast Fourier Transform (FFT)

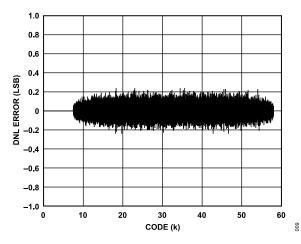


Figure 9. Typical DNL Error

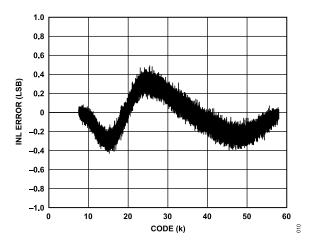


Figure 10. Typical INL Error

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TYPICAL PERFORMANCE CHARACTERISTICS

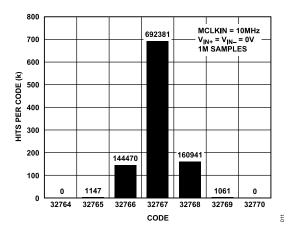


Figure 11. Histogram of Codes at Code Center

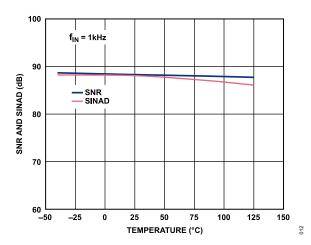


Figure 12. SNR and SINAD vs. Temperature

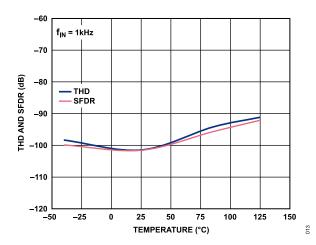


Figure 13. THD and SFDR vs. Temperature

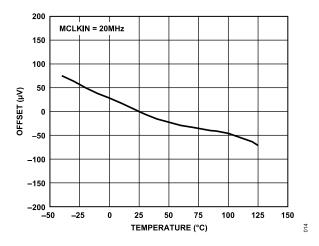


Figure 14. Offset vs. Temperature

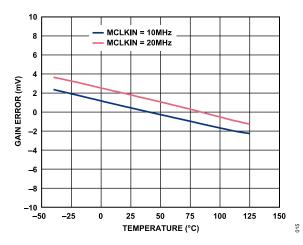


Figure 15. Gain Error vs. Temperature

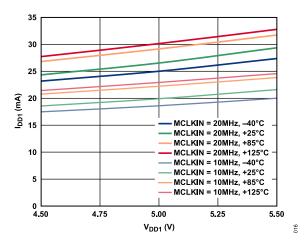


Figure 16. I_{DD1} vs. V_{DD1} at Various Temperatures and Clock Rates

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TYPICAL PERFORMANCE CHARACTERISTICS

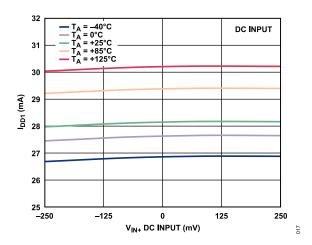


Figure 17. I_{DD1} vs. V_{IN+} DC Input at Various Temperatures

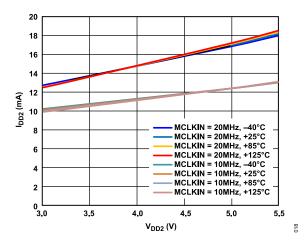


Figure 18. I_{DD2} vs. V_{DD2} at Various Temperatures and Clock Rates

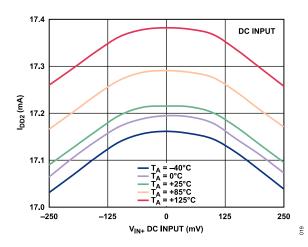


Figure 19. I_{DD2} vs. V_{IN+} DC Input at Various Temperatures

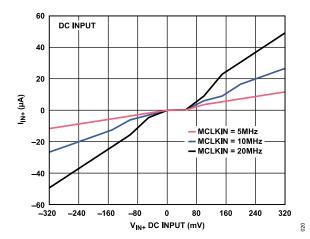


Figure 20. I_{IN+} vs. V_{IN+} DC Input at Various Clock Rates

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TERMINOLOGY

Differential Nonlinearity (DNL)

DNL is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

Integral Nonlinearity (INL)

INL is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are a specified negative full scale, -250 mV (V_{IN+} – V_{IN-}), Code 7168 for the 16-bit level, and a specified positive full scale, +250 mV (V_{IN+} – V_{IN-}), Code 58,368 for the 16-bit level.

Offset Error

Offset error is the deviation of the midscale code (32,768 for the 16-bit level) from the ideal $V_{IN+} - V_{IN-}$ (that is, 0 V).

Gain Error

The gain error includes both positive full-scale gain error and negative full-scale gain error. Positive full-scale gain error is the deviation of the specified positive full-scale code (58,368 for the 16-bit level) from the ideal $V_{\rm IN+}$ – $V_{\rm IN-}$ (250 mV) after the offset error is adjusted out. Negative full-scale gain error is the deviation of the specified negative full-scale code (7168 for the 16-bit level) from the ideal $V_{\rm IN+}$ – $V_{\rm IN-}$ (–250 mV) after the offset error is adjusted out.

Signal-to-Noise-and-Distortion Ratio (SINAD)

SINAD is the measured ratio of signal-to-noise-and-distortion at the output of the ADC. The signal is the rms value of the sine wave, and noise is the rms sum of all nonfundamental signals up to half the sampling frequency ($f_S/2$), including harmonics, but excluding dc

Signal-to-Noise Ratio (SNR)

SNR is the measured signal-to-noise ratio at the output of the ADC. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ($f_S/2$), excluding dc.

The ratio is dependent on the number of quantization levels in the digitization process: the greater the number of levels, the smaller the quantization noise. The theoretical SNR for an ideal N-bit converter with a sine wave input is given by

Signal-to-Noise Ratio =
$$(6.02N + 1.76) dB$$
 (1)

Therefore, for a 12-bit converter, the SNR is 74 dB.

Isolation Transient Immunity

The isolation transient immunity specifies the rate of rise and fall of a transient pulse applied across the isolation boundary, beyond which clock or data is corrupted. The AD7405 was tested using a transient pulse frequency of 100 kHz.

Total Harmonic Distortion (THD)

THD is the ratio of the rms sum of harmonics to the fundamental. For the AD7405, it is defined as

$$THD(dB) = 2\log \frac{\sqrt{v_2^2 + v_3^2 + v_4^2 + v_5^2 + v_6^2}}{v_1}$$
 (2)

where:

 V_1 is the rms amplitude of the fundamental.

 V_2 , V_3 , V_4 , V_5 , and V_6 are the rms amplitudes of the second through the sixth harmonics.

Peak Harmonic or Spurious Noise

Peak harmonic or spurious noise is defined as the ratio of the rms value of the next largest component in the ADC output spectrum (up to $f_{\rm S}/2$, excluding dc) to the rms value of the fundamental. Normally, the value of this specification is determined by the largest harmonic in the spectrum, but for ADCs where the harmonics are buried in the noise floor, it is a noise peak.

Effective Number of Bits (ENOB)

ENOB is defined by

$$ENOB = (SINAD - 1.76)/6.02 \text{ bits}$$
 (3)

Noise Free Code Resolution

Noise free code resolution represents the resolution in bits for which there is no code flicker. The noise free code resolution for an N-bit converter is defined as

Noise Free Code Resolution (Bits) =
$$log_2(2^N/Peak-to-Peak Noise)$$
 (4)

The peak-to-peak noise in LSBs is measured with $V_{IN+} = V_{IN-} = 0 \text{ V}$.

Common-Mode Rejection Ratio (CMRR)

CMRR is defined as the ratio of the power in the ADC output at ± 250 mV frequency, f, to the power of a +250 mV peak-to-peak sine wave applied to the common-mode voltage of V_{IN+} and V_{IN-} of frequency, f_S, as

$$CMRR (dB) = 10 \log(Pf/Pf_S)$$
 (5)

where:

Pf is the power at frequency, f, in the ADC output. Pf_S is the power at frequency, f_S , in the ADC output.

Power Supply Rejection Ratio (PSRR)

Variations in power supply affect the full-scale transition but not the linearity of the converter. PSRR is the maximum change in the specified full-scale (±250 mV) transition point due to a change in power supply voltage from the nominal value.

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CIRCUIT INFORMATION

The AD7405 isolated Σ - Δ modulator converts an analog input signal into a high speed (20 MHz maximum), single-bit data stream; the time average single-bit data from the modulator is directly proportional to the input signal. Figure 21 shows a typical application circuit where the AD7405 is used to provide isolation between the analog input, a current sensing resistor or shunt, and the digital output, which is then processed by a digital filter to provide an N-bit word.

ANALOG INPUT

The differential analog input of the AD7405 is implemented with a switched capacitor circuit. This circuit implements a second-order modulator stage that digitizes the input signal into a single-bit output stream. The sample clock (MCLKIN) provides the clock signal for the conversion process as well as the output data framing clock. This clock source is external on the AD7405. The analog input signal is continuously sampled by the modulator and compared to an internal voltage reference. A digital stream that accurately represents the analog input over time appears at the output of the converter (see Figure 22).

A differential input signal of 0 V ideally results in a differential stream of alternating 1s and 0s at the MDAT \pm output pins. This output is high 50% of the time and low 50% of the time. A differential input of 250 mV produces a stream of 1s and 0s that are high 89.06% of the time. A differential input of -250 mV produces a stream of 1s and 0s that are high 10.94% of the time.

A differential input of 320 mV ideally results in a stream of all 1s. A differential input of -320 mV ideally results in a stream of all 0s. The absolute full-scale range is ± 320 mV, and the specified full-scale performance range is ± 250 mV, as shown in Table 9.

Table 9. Analog Input Range

gpg	
Analog Input	Voltage Input (mV)
Positive Full-Scale Value	+320
Positive Specified Performance Input	+250
Zero	0
Negative Specified Performance Input	-250
Negative Full-Scale Value	-320

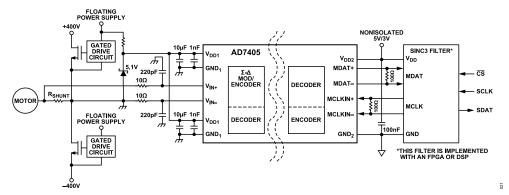


Figure 21. Typical Application Circuit

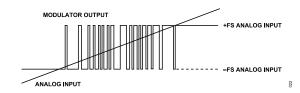


Figure 22. Analog Input vs. Modulator Output

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THEORY OF OPERATION

To reconstruct the original information, this output must be digitally filtered and decimated. A sinc3 filter is recommended because it is one order higher than that of the AD7405 modulator, which is a second-order modulator. If a 256 decimation rate is used, the resulting 16-bit word rate is 78.1 kSPS, assuming a 20 MHz external clock frequency. See the Digital Filter section for more detailed information on the sinc filter implementation. Figure 23 shows the transfer function of the AD7405 relative to the 16-bit output.

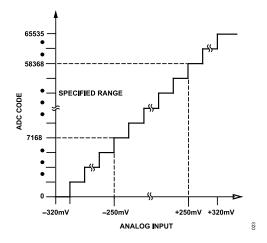


Figure 23. Filtered and Decimated 16-Bit Transfer Function

DIFFERENTIAL INPUTS

The analog input to the modulator is a switched capacitor design. The analog signal is converted into charge by highly linear sampling capacitors. A simplified equivalent circuit diagram of the analog input is shown in Figure 24. A signal source driving the analog input

must provide the charge onto the sampling capacitors every half MCLKIN cycle and settle to the required accuracy within the next half cycle.

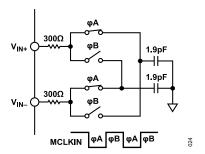


Figure 24. Analog Input Equivalent Circuit

Because the AD7405 samples the differential voltage across its analog inputs, an input circuit provides low common-mode noise at each input attaining low noise performance.

LOW VOLTAGE DIFFERENTIAL SIGNALING (LVDS) INTERFACE

The AD7405 uses an LVDS interface for both the clock input and the modulator output. The benefits of using LVDS in this case helps to make the interface between the modulator and the controller more robust and less susceptible to electromagnetic interference (EMI) from the surroundings. LVDS also helps to reduce the EMI emissions associated with high speed digital signaling. LVDS signals are treated like transmission lines and must be resistively terminated. The value of the differential terminating resistor is typically 100 $\Omega.$ Place the terminating resistor as close to the receiver as possible.

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APPLICATIONS INFORMATION

CURRENT SENSING APPLICATIONS

The AD7405 is ideally suited for current sensing applications where the voltage across a shunt resistor (R_{SHUNT}) is monitored. The load current flowing through an external shunt resistor produces a voltage at the input terminals of the AD7405. The AD7405 provides isolation between the analog input from the current sensing resistor and the digital outputs. By selecting the appropriate shunt resistor value, a variety of current ranges can be monitored.

Choosing R_{SHUNT}

The shunt resistor (R_{SHUNT}) values used in conjunction with the AD7405 are determined by the specific application requirements in terms of voltage, current, and power. Small resistors minimize power dissipation, whereas low inductance resistors prevent any induced voltage spikes, and good tolerance devices reduce current variations. The final values chosen are a compromise between low power dissipation and accuracy. Higher value resistors use the full performance input range of the ADC, thus achieving maximum SNR performance. Low value resistors dissipate less power but do not use the full performance input range. The AD7405, however, delivers excellent performance, even with lower input signal levels, allowing low value shunt resistors to be used while maintaining system performance.

To choose a suitable shunt resistor, first determine the current through the shunt. The shunt current for a 3-phase induction motor can be expressed as

$$I_{RMS} = \frac{P_W}{1.73 \times V \times EF \times PF} \tag{6}$$

where:

 I_{RMS} is the motor phase current (A rms). P_W is the motor power (Watts). V is the motor supply voltage (V ac). EF is the motor efficiency (%). PF is the power efficiency (%).

To determine the shunt peak sense current, I_{SENSE} , consider the motor phase current and any overload that may be possible in the system. When the peak sense current is known, divide the voltage range of the AD7405 (±250 mV) by the peak sense current to yield a maximum shunt value.

If the power dissipation in the shunt resistor is too large, the shunt resistor can be reduced and less of the ADC input range can be used. Figure 25 shows the SINAD performance characteristics and the ENOB of resolution for the AD7405 for different input signal amplitudes. Figure 26 shows the rms noise performance for dc input signal amplitudes. The AD7405 performance at lower input signal ranges allows smaller shunt values to be used while still maintaining a high level of performance and overall system efficiency.

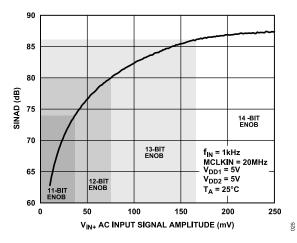


Figure 25. SINAD vs. V_{IN+} AC Input Signal Amplitude

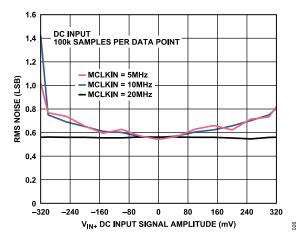


Figure 26. RMS Noise vs. V_{IN+} DC Input Signal Amplitude

R_{SHUNT} must be able to dissipate the I2R power losses. If the power dissipation rating of the resistor is exceeded, its value may drift or the resistor may be damaged, resulting in an open circuit. This open circuit can result in a differential voltage across the terminals of the AD7405, in excess of the absolute maximum ratings. If I_{SENSE} has a large, high frequency component, choose a resistor with low inductance.

VOLTAGE SENSING APPLICATIONS

The AD7405 can also be used for isolated voltage monitoring. For example, in motor control applications, it can be used to sense the bus voltage. In applications where the voltage being monitored exceeds the specified analog input range of the AD7405, a voltage divider network can be used to reduce the voltage being monitored to the required range.

INPUT FILTER

In a typical application, where voltage is being measured across a shunt resistor, connect the AD7405 directly across the shunt resistor with a simple RC low-pass filter on each input.

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APPLICATIONS INFORMATION

The recommended circuit configuration for driving the differential inputs to achieve best performance is shown in Figure 27. An RC low-pass filter is placed on both the analog input pins. Recommended values for the resistors and capacitors are 10 Ω and 220 pF, respectively. If possible, equalize the source impedance on each analog input to minimize offset.

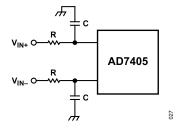


Figure 27. RC Low-Pass Filter Input Network

The input filter configuration for the AD7405 is not limited to the low-pass structure shown in Figure 27. The differential RC filter configuration shown in Figure 28 also achieves excellent performance. Recommended values for the resistors and capacitor are 22 Ω and 47 pF, respectively.

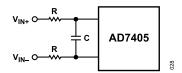


Figure 28. Differential RC Filter Input Network

Figure 29 compares the typical performance for the input filter structures outlined in Figure 27 and Figure 28 for different resistor and capacitor values.

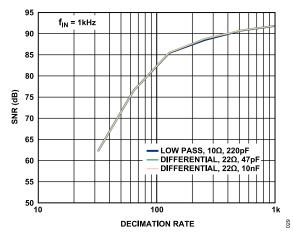


Figure 29. SNR vs. Decimation Rate for Different Filter Structures for Different Resistor and Capacitor Values

DIGITAL FILTER

The output of the AD7405 is a continuous LVDS digital bit stream. To reconstruct the original input signal information, this output bit stream needs to be digitally filtered and decimated. A sinc filter is

recommended due to its simplicity. A sinc3 filter is recommended because it is one order higher than that of the AD7405 modulator, which is a second-order modulator. The type of filter selected, the decimation rate, and the modulator clock used determines the overall system resolution and throughput rate. The higher the decimation rate, the greater the system accuracy, as illustrated in Figure 30. However, there is a trade-off between accuracy and throughput rate and, therefore, higher decimation rates result in lower throughput solutions. Note that for a given bandwidth requirement, a higher MCLKIN frequency can allow higher decimation rates to be used, resulting in higher SNR performance.

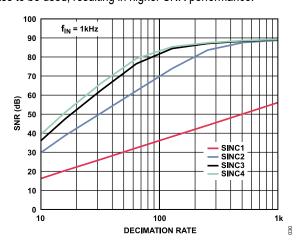


Figure 30. SNR vs. Decimation Rate for Different Sinc Filter Orders

A sinc3 filter is recommended for use with the AD7405. This filter can be implemented on a field programmable gate array (FPGA) or a digital signal processor (DSP).

Equation 7 describes the transfer function of a sinc filter.

$$H(z) = \left(\frac{1(1 - Z^{-DR})}{DR(1 - Z^{-1})}\right)^{N} \tag{7}$$

where *DR* is the decimation rate and *N* is the sinc filter order.

The throughput rate of the sinc filter is determined by the modulator clock and the decimation rate selected.

$$Throughput = \frac{MCLK}{DR}$$
 (8)

where MCLK is the modulator clock frequency

As the decimation rate increases, the data output size from the sinc filter increases. The output data size is expressed in Equation 9. The 16 most significant bits are used to return a 16-bit result.

$$Data \quad size = N \times \log_2 \quad DR \tag{9}$$

For a sinc3 filter, the -3 dB filter response point can be derived from the filter transfer function, Equation 7, and is 0.262 times the throughput rate. The filter characteristics for a third-order sinc3 filter are summarized in Table 10.

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Table 10. Sinc3 Filter Characteristics for 20 MHz MCLKIN

Decimation Ratio (DR)	Throughput Rate (kHz)	Output Data Size (Bits)	Filter Response (kHz)
32	625	15	163.7
64	312.5	18	81.8
128	156.2	21	40.9
256	78.1	24	20.4
512	39.1	27	10.2

The following Verilog code provides an example of a sinc3 filter implementation on a Xilinx® Spartan®-6 FPGA. Note that the data is read on the positive clock edge. It is recommended to read in the data on the positive clock edge. The code is configurable to accommodate decimation rates from 32 to 4096.

```
module dec256sinc24b
input mclk1, /* used to clk filter */
input reset, /* used to reset filter */
input mdata1, /* input data to be filtered */
output reg [15:0] DATA, /* filtered output */
output reg data en,
input [15:0] dec rate
);
/* Data is read on positive clk edge */
reg [36:0] ip_data1;
reg [36:0] acc1;
reg [36:0] acc2;
reg [36:0] acc3;
reg [36:0] acc3 d2;
reg [36:0] diff1;
reg [36:0] diff2;
reg [36:0] diff3;
reg [36:0] diff1 d;
reg [36:0] diff2 d;
reg [15:0] word count;
reg word clk;
reg enable;
/*Perform the Sinc action*/
always @ (mdata1)
if (mdata1==0)
       ip data1 <= 37'd0;
       /* change 0 to a -1 for twos complement
*/
else
       ip data1 <= 37'd1;
/*Accumulator (Integrator)
Perform the accumulation (IIR) at the speed of
the modulator.
Z = one sample delay MCLKOUT = modulators con▶
```

```
WCLKIN

ACC1+
ACC2+
ACC3+

IP_DATA1

Z

ACC3+
```

Figure 31. Accumulator

```
always @ (negedge mclk1, posedge reset)
begin
       if (reset)
       begin
       /* initialize acc registers on reset */
              acc1 <= 37'd0;
              acc2 <= 37'd0;
              acc3 <= 37'd0;
       end
       else
       begin
       /*perform accumulation process */
              acc1 <= acc1 + ip data1;</pre>
              acc2 \le acc2 + acc1;
              acc3 \le acc3 + acc2;
       end
end
/*decimation stage (MCLKOUT/WORD CLK) */
always @ (posedge mclk1, posedge reset)
begin
       if (reset)
              word count <= 16'd0;</pre>
       else
       begin
              if ( word count == dec rate - 1 )
                      word count <= 16'd0;
              else
                      word count <= word count
+ 16'b1;
       end
end
always @ ( posedge mclk1, posedge reset )
begin
       if ( reset )
              word clk <= 1'b0;
       else
       begin
              if ( word count == dec rate/2 -
1)
                      word clk <= 1'b1;
              else if ( word count == dec rate
- 1 )
                      word clk <= 1'b0;
       end
```

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```
/*Differentiator (including decimation stage)
Perform the differentiation stage (FIR) at a
lower speed.
Z = one sample delay WORD_CLK = output word
rate */
```

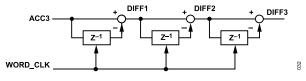


Figure 32. Differentiator

```
always @ (posedge word clk, posedge reset)
begin
       if (reset)
       begin
               acc3 d2 <= 37'd0;
               diff\overline{1} d \leftarrow 37'd0;
               diff2 d <= 37'd0;
               diff1 <= 37'd0;
               diff2 <= 37'd0;
               diff3 <= 37'd0;
       end
       else
       begin
               diff1 <= acc3 - acc3 d2;</pre>
               diff2 \le diff1 - diff1 d;
               diff3 <= diff2 - diff2 d;
               acc3 d2 <= acc3;
               diff1 d <= diff1;
               diff2 d <= diff2;</pre>
       end
end
/* Clock the Sinc output into an output regis▶
WORD CLK = output word rate */
```

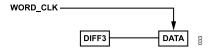


Figure 33. Clocking Sinc3 Output into an Output Register

```
always @ ( posedge word_clk )
begin
```

```
case ( dec rate )
              16'd32:begin
                     DATA <= (diff3[15:0] ==
16'h8000) ? 16'hFFFF : {diff3[14:0], 1'b0};
              16'd64:begin
                     DATA <= (diff3[18:2] ==
17'h10000) ? 16'hFFFF : diff3[17:2];
              end
              16'd128:begin
                     DATA <= (diff3[21:5] ==
17'h10000) ? 16'hFFFF : diff3[20:5];
              end
              16'd256:begin
                     DATA <= (diff3[24:8] ==
17'h10000) ? 16'hFFFF : diff3[23:8];
              end
              16'd512:begin
                     DATA <= (diff3[27:11] ==
17'h10000) ? 16'hFFFF : diff3[26:11];
              end
              16'd1024:begin
                     DATA <= (diff3[30:14] ==
17'h10000) ? 16'hFFFF : diff3[29:14];
              16'd2048:begin
                     DATA <= (diff3[33:17] ==
17'h10000) ? 16'hFFFF : diff3[32:17];
              end
              16'd4096:begin
                     DATA <= (diff3[36:20] ==
17'h10000) ? 16'hFFFF : diff3[35:20];
              end
              default:begin
                     DATA <= (diff3[24:8] ==
17'h10000) ? 16'hFFFF : diff3[23:8];
       endcase
end
/* Synchronize Data Output*/
always@ ( posedge mclk1, posedge reset )
begin
       if ( reset )
       begin
              data en <= 1'b0;
              enable <= 1'b1;
       end
       else
       begin
              if ( (word count == dec rate/2 -
 1) && enable )
              begin
                     data en <= 1'b1;
                     enable <= 1'b0;
```

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APPLICATIONS INFORMATION

GROUNDING AND LAYOUT

It is recommended to decouple the V_{DD1} supply with a 10 μF capacitor in parallel with a 1 nF capacitor to $GND_1.$ Decouple Pin 1 and Pin 7 individually. Decouple the V_{DD2} supply with a 100 nF value to $GND_2.$ In applications involving high common-mode transients, minimize board coupling across the isolation barrier. Furthermore, design the board layout so that any coupling that occurs equally affects all pins on a given component side. Failure to ensure equal coupling can cause voltage differentials between pins to exceed the absolute maximum ratings of the device, thereby leading to latch-up or permanent damage. Place any decoupling used as close to the supply pins as possible.

Minimize series resistance in the analog inputs to avoid any distortion effects, especially at high temperatures. If possible, equalize the source impedance on each analog input to minimize offset. To reduce offset drift, check for mismatch and thermocouple effects on the analog input printed circuit board (PCB) tracks.

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OUTLINE DIMENSIONS

Package Drawing (Option)	Package Type	Package Description
RI-16-2	SOIC_IC	16-Lead Standard Small Outline Package, with Increased Creepage

For the latest package outline information and land patterns (footprints), go to Package Index.

Updated: January 10, 2024

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Packing Quantity	Package Option
AD7405BRIZ	-40°C to +125°C	16-Lead SOIC (Increased Creepage)		RI-16-2
AD7405BRIZ-RL	-40°C to +125°C	16-Lead SOIC (Increased Creepage)	Reel, 1000	RI-16-2
AD7405BRIZ-RL7	-40°C to +125°C	16-Lead SOIC (Increased Creepage)	Reel, 400	RI-16-2

¹ Z = RoHS Compliant Part.

EVALUATION BOARDS

Model ¹	Description
EVAL-AD7405FMCZ	Evaluation Board

¹ Z = RoHS Compliant Part.

